



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants : Yasuhiro NONAKA et al.

Group Art Unit : 2852

Appl. No. : 10/765,974

Examiner : Not Yet Assigned

Filed : January 29, 2004

Confirmation No. : 2945

For : HEAT GENERATING APPARATUS USING ELECTROMAGNETIC  
INDUCTION

**SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT**

Commissioner for Patents  
U.S. Patent and Trademark Office  
220 20th Street S.  
Customer Window, Mail Stop \_\_\_\_\_  
Crystal Plaza Two, Lobby, Room 1B03  
Arlington, VA 22202

Sir :

In accordance with the duty of disclosure under 37 C.F.R. §1.56 and §§1.97-1.98,  
Applicants hereby submit a copy of an International Search Report that was mailed on  
September 13, 2004, with respect to patent family member International Patent  
Application No. PCT/JP2004/000805, in which the following documents were cited:

Japanese Laid-Open Patent Publication No. 2002-236429, together with an  
English language Abstract of the same;

Japanese Laid-Open Patent Publication No. 2003-17221, together with an English  
language Abstract of the same;

Japanese Laid-Open Patent Publication No. 2002-214962, together with an  
English language Abstract of the same and patent family member U.S. Patent Application  
Publication No. 2002/130945;

Japanese Laid-Open Patent Publication No. 2002-174982, together with an English language Abstract of the same;

U.S. Patent No. 4,467,165; and

Japanese Laid-Open Patent Publication No. 2002-208469, together with an English language Abstract of the same.

The category of relevance, pertinent portions, and claims to which each document is relevant, as ascertained by the European Examiner applying International rules to the International claims are set forth in the International Search Report.

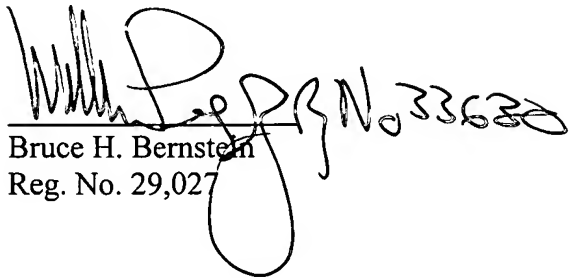
Further to the U.S. Patent and Trademark Office's decision to waive the requirement under 37 C.F.R. §1.98 (a)(2)(i), copies of the U.S. patent and U.S. patent application publication are not enclosed herewith. However, if any copies are needed, the Examiner is respectfully requested to contact the undersigned.

Applicants respectfully request that the Examiner consider the above material and cite the same. Copies of the above-noted foreign documents are attached hereto and all of the documents are listed on the attached PTO-1449 Form. A copy of the International Search Report is also attached hereto. The Examiner is requested to initial the appropriate spaces on the attached Form and to return a copy of the completed Form to Applicants with the next official communication in the present application.

Applicants note that an Office Action on the merits has not issued in the present application, and thus no fee is believed necessary to ensure consideration of the submitted material.

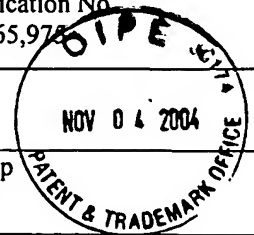
Should the Examiner have any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully Submitted,  
Yasuhiro NONAKA et al.

  
Bruce H. Bernstein  
Reg. No. 29,027

November 4, 2004  
GREENBLUM & BERNSTEIN, P.L.C.  
1950 Roland Clarke Place  
Reston, VA 20191  
(703) 716-1191

FORM PTO-1449

U.S. Department of Commerce  
Patent and Trademark OfficeAtty. Docket No.  
P24876Application No.  
10/765,978INFORMATION DISCLOSURE STATEMENT  
BY APPLICANT  
(Use several sheets if necessary)Applicant  
Yasuhiro NONAKA et al.Filing Date  
January 29, 2004Group  
2852

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER								DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	2002	/	1	3	0	9	4	5		09/19/02	SAMEI et al.			
		4	4	6	7	1	6	5		08/21/84	KIUCHI et al.			

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER								DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
	2002	-	2	3	6	4	2	9		08/23/02	JAPAN				
	2003	-		1	7	2	2	1		01/17/03	JAPAN				
	2002	-	2	1	4	9	6	2		07/31/02	JAPAN				
	2002	-	1	7	4	9	8	2		06/21/02	JAPAN				
	2002	-	2	0	8	4	6	9		07/26/02	JAPAN				

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	1	English language Abstract of JP 2002-236429.
	2	English language Abstract of JP 2003-17221.
	3	English language Abstract of JP 2002-214962.
	4	English language Abstract of JP 2002-174982
	5	English language Abstract of JP 2002-208469.

EXAMINER

DATE CONSIDERED

\*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

BEST AVAILABLE COPY